Search Notes

Application/Control No.	Applicant(s)/Patent un Reexamination	der
10/761,835	CHOI, JONG-KON	
Examiner	Art Unit	
James M. Mitchell	2813	

James M. Mitchell

	SEARCHED				
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East (See printout)	2/21/06	744		
257/782,783 (See printout)				
438/15,25,26 118 (sec printout)				